

# FDS6690S

# 30V N-Channel PowerTrench<sup>Ò</sup> SyncFET<sup>™</sup>

### **General Description**

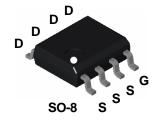
The FDS6690S is designed to replace a single SO-8 MOSFET and Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $R_{\rm DS(ON)}$  and low gate charge. The FDS6690S includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology. The performance of the FDS6690S as the low-side switch in a synchronous rectifier is close to the performance of the FDS6690A in parallel with a Schottky diode.

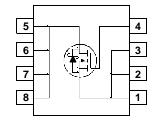
### **Applications**

- DC/DC converter
- Motor drives

#### **Features**

- 10 A, 30 V.  $R_{DS(ON)} = 0.016 \ \Omega \ @V_{GS} = 10 \ V$   $R_{DS(ON)} = 0.024 \ \Omega \ @V_{GS} = 4.5 \ V$
- Includes SyncFET Schottky diode
- Low gate charge (11 nC typical)
- High performance trench technology for extremely low R<sub>DS/ON</sub>
- · High power and current handling capability





### Absolute Maximum Ratings TA=25°C unless otherwise noted

| Symbol                            | Parameter                               | Ratings     | Units |   |
|-----------------------------------|---|-------------|-------|---|
| V <sub>DSS</sub>                  | Drain-Source Voltage                    |             | 30    | V |
| V <sub>GSS</sub>                  | Gate-Source Voltage                     |             | ±20   | V |
| I <sub>D</sub>                    | Drain Current - Continuous              | (Note 1a)   | 10    | А |
|                                   | - Pulsed                                |             | 50    |   |
| $P_D$                             | Power Dissipation for Single Operation  | (Note 1a)   | 2.5   | W |
|                                   |   | (Note 1b)   | 1.2   |   |
|                                   |   | (Note 1c)   | 1     |   |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperat | -55 to +150 | °C    |   |

## **Thermal Characteristics**

| R <sub>0JA</sub>  | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 50 | °C/W |
|-------------------|---|-----------|----|------|
| R <sub>0</sub> JC | Thermal Resistance, Junction-to-Case    | (Note 1)  | 25 | °C/W |

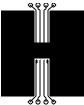
### **Package Marking and Ordering Information**

| Device Marking | Device Marking Device |  | Tape width | Quantity   |  |
|----------------|-----------------------|--|------------|------------|--|
| FDS6690S       | FDS6690S FDS6690S     |  | 12mm       | 2500 units |  |

| Symbol                               | Parameter   | Test Conditions   | Min | Тур            | Max            | Units |
|--------------------------------------|---|---|-----|----------------|----------------|-------|
| Off Char                             | acteristics                                       |   |     |                |                |       |
| BV <sub>DSS</sub>                    | Drain-Source Breakdown Voltage                    | $V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ mA}$  | 30  |                |                | V     |
| <u>ΔBV DSS</u><br>ΔTJ                | Breakdown Voltage Temperature Coefficient         | I <sub>D</sub> = 1 mA, Referenced to 25°C   |     | 23             |                | mV/°C |
| l <sub>DSS</sub>                     | Zero Gate Voltage Drain Current                   | $V_{DS} = 24 \text{ V},  V_{GS} = 0 \text{ V}$  |     |                | 1              | mA    |
| I <sub>GSSF</sub>                    | Gate-Body Leakage, Forward                        | $V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$  |     |                | 100            | nA    |
| I <sub>GSSR</sub>                    | Gate-Body Leakage, Reverse                        | $V_{GS} = -20 \text{ V}$ $V_{DS} = 0 \text{ V}$   |     |                | -100           | nA    |
| On Char                              | acteristics (Note 2)                              |   |     |                |                |       |
| V <sub>GS(th)</sub>                  | Gate Threshold Voltage                            | $V_{DS} = V_{CS}$ , $I_D = 1 \text{ mA}$  | 1   | 2.4            | 3              | V     |
| ΔV <sub>GS(th)</sub> ΔT <sub>J</sub> | Gate Threshold Voltage<br>Temperature Coefficient | I <sub>D</sub> = 1 mA, Referenced to 25°C   |     | -6             |                | mV/°C |
| R <sub>DS(on)</sub>                  | Static Drain–Source<br>On–Resistance              | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A<br>V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 8.5 A<br>V <sub>GS</sub> =10 V, I <sub>D</sub> = 10 A, T <sub>J</sub> =125°C |     | 13<br>20<br>19 | 16<br>24<br>26 | mΩ    |
| I <sub>D(on)</sub>                   | On-State Drain Current                            | $V_{GS} = 10 \text{ V}, \qquad V_{DS} = 5 \text{ V}$  | 50  |                |                | Α     |
| <b>g</b> FS                          | Forward Transconductance                          | $V_{DS} = 15 \text{ V}, \qquad I_{D} = 10 \text{ A}$  |     | 26             |                | S     |
| Dvnamic                              | Characteristics                                   |   |     |                |                |       |
| Ciss                                 | Input Capacitance                                 | $V_{DS} = 15 \text{ V}, \qquad V_{GS} = 0 \text{ V},$   |     | 1233           |                | pF    |
| Coss                                 | Output Capacitance                                | f = 1.0 MHz   |     | 344            |                | pF    |
| C <sub>rss</sub>                     | Reverse Transfer Capacitance                      |   |     | 106            |                | pF    |
| Switchin                             | g Characteristics (Note 2)                        |   |     |                |                |       |
| t <sub>d(on)</sub>                   | Turn-On Delay Time                                | $V_{DS} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A}, $ $V_{CS} = 10 \text{ V}. \qquad R_{GEN} = 6 \Omega$  |     | 8              | 16             | ns    |
| t <sub>r</sub>                       | Turn-On Rise Time                                 | $V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$  |     | 5              | 10             | ns    |
| t <sub>d(off)</sub>                  | Turn-Off Delay Time                               |   |     | 25             | 40             | ns    |
| t <sub>f</sub>                       | Turn-Off Fall Time                                |   |     | 11             | 20             | ns    |
| Qg                                   | Total Gate Charge                                 | $V_{DS} = 15 \text{ V}, \qquad I_{D} = 10 \text{ A},$   |     | 11             | 18             | nC    |
| Q <sub>gs</sub>                      | Gate-Source Charge                                | $V_{GS} = 5 V$  |     | 5              |                | nC    |
| Q <sub>gd</sub>                      | Gate-Drain Charge                                 |   |     | 4              |                | nC    |
| Drain-Se                             | ource Diode Characteristics                       | and Maximum Ratings   |     |                |                |       |
| ls                                   | Maximum Continuous Drain-Source                   |   |     |                | 3.5            | Α     |
| V <sub>SD</sub>                      | Drain–Source Diode Forward<br>Voltage             | $V_{GS} = 0 \text{ V},  I_S = 3.5 \text{ A}$ (Note 2)   |     | 0.5            | 0.7            | V     |
| t <sub>rr</sub>                      | Diode Reverse Recovery Time                       | I <sub>F</sub> = 10A  |     | 17             |                | nS    |
| Q <sub>rr</sub>                      | Diode Reverse Recovery Charge                     | $d_{iF}/d_t = 300 \text{ A/}\mu\text{s}$ (Note 3)   |     | 12.5           |                | nC    |

#### Notes:

 R<sub>8JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>8JC</sub> is guaranteed by design while R<sub>8CA</sub> is determined by the user's board design.



a) 50°/W when mounted on a 1in² pad of 2 oz copper



b) 105°/W when mounted on a .04 in² pad of 2 oz copper



c) 125°/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width <  $300\mu s$ , Duty Cycle < 2.0%

3. See "SyncFET Schottky body diode characteristics" below.

## **Typical Characteristics**

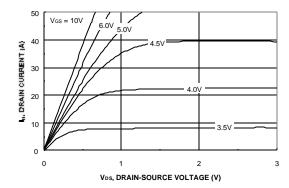


Figure 1. On-Region Characteristics.

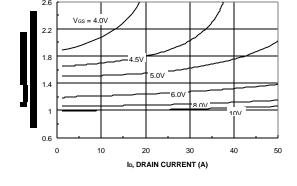


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

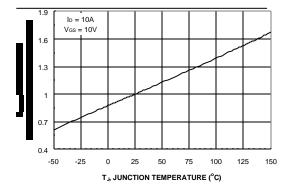


Figure 3. On-Resistance Variation with Temperature.

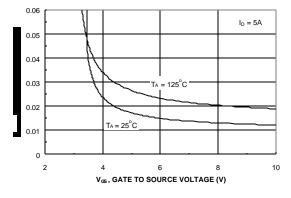


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

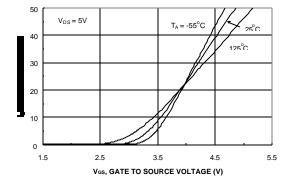


Figure 5. Transfer Characteristics.

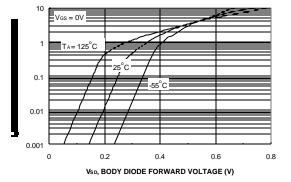
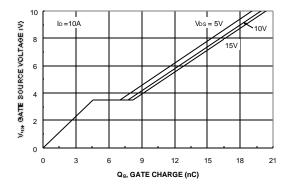


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



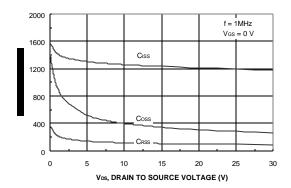
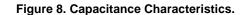
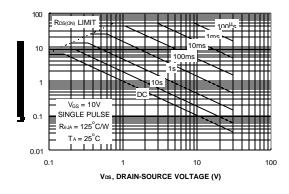


Figure 7. Gate Charge Characteristics.





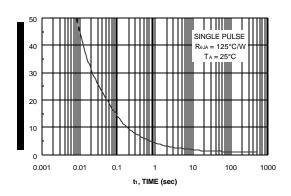


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

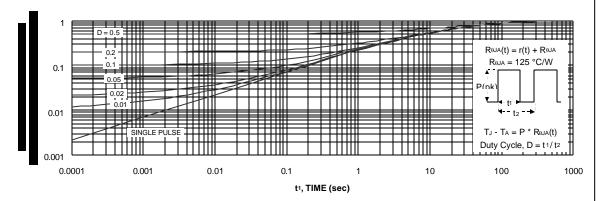


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

### **Typical Characteristics** (continued)

# SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS6690S.

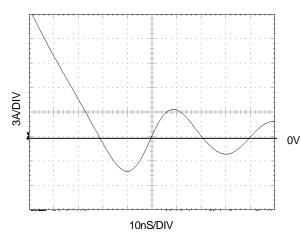


Figure 12. FDS6690S SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6690A).

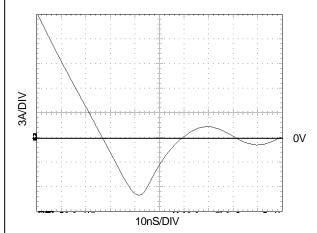


Figure 13. Non-SyncFET (FDS6690A) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

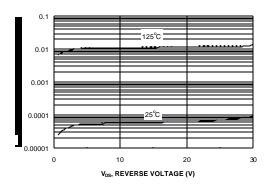
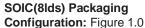
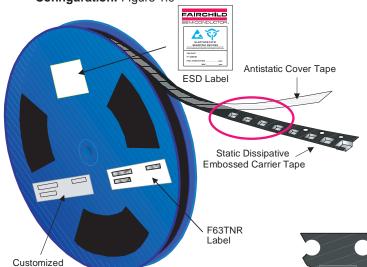


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

### **SO-8 Tape and Reel Data and Package Dimensions**







#### Packaging Description:

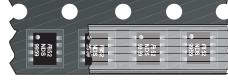
Packaging Description:

SOIC-8 parts are shipped in tape. The carrier tape is made from a dissipative (carbon filled) polycarbonate resin. The cover tape is a multilayer film (Heat Activated Adhesive in nature) primarily composed of polyester film, adhesive layer, sealant, and amit-static sprayed agent. These reeled parts in standard option are shipped with 2,500 units per 13° or 300cm diameter reel. The reels are dark blue in color and is made of polystyrene plastic (antistatic coated). Other option comes in 500 units per 7° or 177cm diameter reel. This and some other options are further described in the Packaging Information table.

These full reles are individually barcode labeled and placed inside a standard intermediate box (illustrated in figure 1.0) made of recyclable corrugated brown paper. One box contains two reels maximum. And these boxes are placed inside a barcode labeled shipping box which comes in different sizes depending on the number of parts shipped.

ESD Label

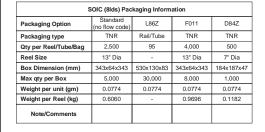
F63TN Label



343mm x 342mm x 64mm Standard Intermediate box



**SOIC-8 Unit Orientation** 

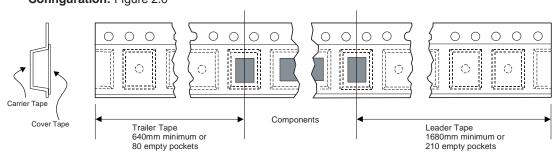


#### F63TNR Label sample

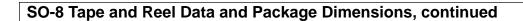
Label



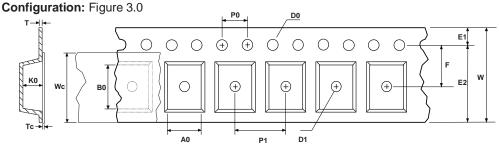
# **SOIC(8lds) Tape Leader and Trailer Configuration:** Figure 2.0



F63TNL



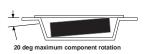
## SOIC(8lds) Embossed Carrier Tape



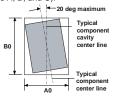


| Dimensions are in millimeter |                 |                 |                |                 |                 |                 |              |                 |               |               |                |                       |               |                 |
|------------------------------|-----------------|-----------------|----------------|-----------------|-----------------|-----------------|--------------|-----------------|---------------|---------------|----------------|-----------------------|---------------|-----------------|
| Pkg type                     | Α0              | В0              | w              | D0              | D1              | E1              | E2           | F               | P1            | P0            | K0             | т                     | Wc            | Тс              |
| SOIC(8lds)<br>(12mm)         | 6.50<br>+/-0.10 | 5.30<br>+/-0.10 | 12.0<br>+/-0.3 | 1.55<br>+/-0.05 | 1.60<br>+/-0.10 | 1.75<br>+/-0.10 | 10.25<br>min | 5.50<br>+/-0.05 | 8.0<br>+/-0.1 | 4.0<br>+/-0.1 | 2.1<br>+/-0.10 | 0.450<br>+/-<br>0.150 | 9.2<br>+/-0.3 | 0.06<br>+/-0.02 |

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



Sketch B (Top View)

Component Rotation

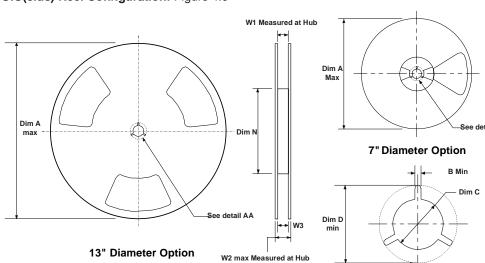


Sketch C (Top View)

Component lateral movement

DETAIL AA

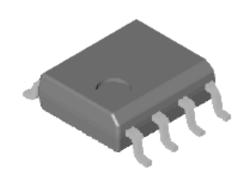
### SOIC(8lds) Reel Configuration: Figure 4.0

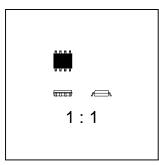


| Dimensions are in inches and millimeters |                |               |              |                                   |               |             |                                  |               |                              |
|--|----------------|---------------|--------------|-----------------------------------|---------------|-------------|----------------------------------|---------------|------------------------------|
| Tape Size                                | Reel<br>Option | Dim A         | Dim B        | Dim C                             | Dim D         | Dim N       | Dim W1                           | Dim W2        | Dim W3 (LSL-USL)             |
| 12mm                                     | 7" Dia         | 7.00<br>177.8 | 0.059<br>1.5 | 512 +0.020/-0.008<br>13 +0.5/-0.2 | 0.795<br>20.2 | 2.165<br>55 | 0.488 +0.078/-0.000<br>12.4 +2/0 | 0.724<br>18.4 | 0.469 - 0.606<br>11.9 - 15.4 |
| 12mm                                     | 13" Dia        | 13.00<br>330  | 0.059<br>1.5 | 512 +0.020/-0.008<br>13 +0.5/-0.2 | 0.795<br>20.2 | 7.00<br>178 | 0.488 +0.078/-0.000<br>12.4 +2/0 | 0.724<br>18.4 | 0.469 - 0.606<br>11.9 - 15.4 |

## SO-8 Tape and Reel Data and Package Dimensions, continued

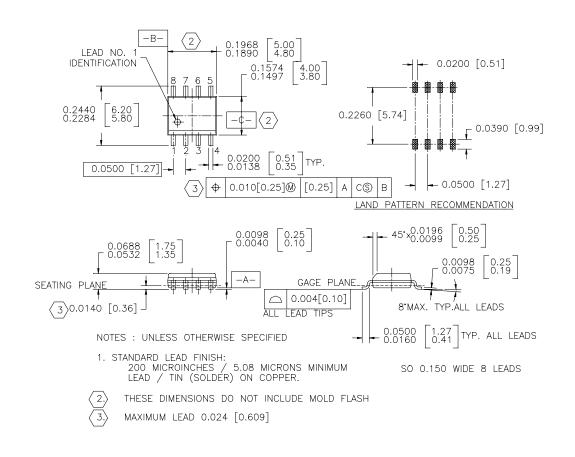
# SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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FAST<sup>®</sup> Quiet Series<sup>™</sup> SuperSOT<sup>™</sup>-3 GTO<sup>™</sup> SuperSOT<sup>™</sup>-6

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### PRODUCT STATUS DEFINITIONS

#### **Definition of Terms**

| Datasheet Identification | Product Status            | Definition  |
|--------------------------|---------------------------|---|
| Advance Information      | Formative or<br>In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.  |
| Preliminary              | First Production          | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| No Identification Needed | Full Production           | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.   |
| Obsolete                 | Not In Production         | This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.   |